



Customer No. 04249

Sheet 1 of 3

DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE LIST OF DOCUMENTS CITED BY APPLICANT <i>(Use several sheets if necessary)</i>									ATTY. DOCKET NO.	SERIAL NO.	
									39,816-04	10/676,930	
									APPLICANT		
									Sawchuk, et. al.		
									FILING DATE	GROUP	
									September 30, 2003	3744	

U.S. PATENT DOCUMENTS

*EXAMINER INITIAL		DOCUMENT NUMBER								DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE	
		6	1	6	8	7	6	8							
<i>2d</i>	AA	6	1	6	8	7	6	8	11/01	Taylor et. al	—	—	—	—	
<i>2d</i>	AB	6	3	8	9	8	4	4	5/02	Klein Nagel Voort	—	—	—	—	
	AC														
	AD														
	AE														
	AF														
	AG														
	AH														
	AI														
	AJ														
	AK														

FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER								DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
		0	1	8	1	8	4	5						YES	NO
<i>2d</i>	AL	0	1	8	1	8	4	5	11/01	WO	—	—	—	—	X
<i>2d</i>	AM	0	3	6	4	9	4	6	8/03	WO	—	—	—	—	X
<i>2d</i>	AN	0	3	6	4	9	4	7	8/03	WO	—	—	—	—	X
	AO														
	AP														

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, etc.)

	AR	C. Th. Sanders, "De technologie van vloeibaar aardgas ontwikkeling en toekomst" Koude Klim. Vol 82, No. 8 (8/1989) Pages 33-37												
	AS	Collins et al., "Liquefaction Plant Design in the 1990s", Hydrocarbon Processing, Gulf Publishing Co., Houston, TX Vol. 74, No. 4 (April 1995) P. 67-76												
	AT	Kosseim et al., "New Developments in Gas Purification for LNG Plants", IGT Int'l Inst. Of Refrig. 10 th LNG Conf. (5/1992)												

EXAMINER <i>Willa C Doehl</i>	DATE CONSIDERED <i>6-2-05</i>
• EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.	

U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE			ATTY. DOCKET NO. 39,816-04	SERIAL NO. 10/676,930
LIST OF DOCUMENTS CITED BY APPLICANT (Use several sheets if necessary)			APPLICANT Sawchuk, et al.	
			FILING DATE September 30, 2003	GROUP

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	AA						
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		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION
							YES NO
	AL						
	AM						
	AN						
	AO						
	AP						

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, etc.)

<i>2</i>	AR	A. Avidar et al., "Large LNG Plants" Phillips Pct. Website (May 2002)				
<i>MS</i>	AS	James H.R.: "Modular and Barge-Mounted Process Plants", AIChE Nat'l Meeting (3/1982)				
<i>MS</i>	AT	Search Reports - PCT/US03/30551; PCT/US03/31252				
EXAMINER <i>Willa C. Quash</i>		DATE CONSIDERED <i>6-7-05</i>				
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		APPLICANT Sawchuk, et al.	
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	AK						

FOREIGN PATENT DOCUMENTS

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							YES NO
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	AM						
	AN						
	AO						
	AP						

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, etc.)

<i>one</i>	AR	
		Sawchuk et al., US Patent Application, Serial No. 10/674,246 filed September 29, 2003
	AS	
	AT	

EXAMINER *Walter C. Deard* DATE CONSIDERED *6-7-05*

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